

## General Description

The VSM78N07 uses advanced trench technology and design to provide excellent  $R_{DS(ON)}$  with low gate charge. This device is suitable for use in PWM, load switching and general purpose applications.

## Features

- $V_{DS}=75V$ ;  $I_D=78A$  @  $V_{GS}=10V$ ;  
 $R_{DS(ON)} < 8.5m\Omega$  @  $V_{GS}=10V$
- Special process technology for high ESD capability
- Special designed for Convertors and power controls
- High density cell design for ultra low  $R_{dson}$
- Fully characterized Avalanche voltage and current
- Good stability and uniformity with high  $E_{AS}$
- Excellent package for good heat dissipation

## Application

- Power switching application
- Hard switched and high frequency circuits
- Uninterruptible power supply



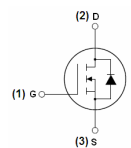
TO-220C

### Product Summary

$BV_{DSS}$	typ.	84	V
$R_{DS(ON)}$	typ.	7.0	m $\Omega$
	max.	8.5	m $\Omega$
$I_D$		78	A



TO-220-3L top view



Schematic Diagram

## Package Marking and Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
VSM78N07-TC	VSM78N07	TO-220C	-	-	-

**Table 1. Absolute Maximum Ratings ( $T_C=25^\circ C$ )**

Parameter	Symbol	Value	Unit
Drain-Source Voltage ( $V_{GS}=0V$ )	$V_{DS}$	75	V
Gate-Source Voltage ( $V_{DS}=0V$ )	$V_{GS}$	$\pm 20$	V
Drain Current (DC) at $T_C=25^\circ C$	$I_{D(DC)}$	78	A
Drain Current (DC) at $T_C=100^\circ C$	$I_{D(DC)}$	55	A
Drain Current-Continuous@ Current-Pulsed (Note 1)	$I_{DM(pluse)}$	300	A
Peak diode recovery voltage	$dv/dt$	30	V/ns
Maximum Power Dissipation( $T_C=25^\circ C$ )	$P_D$	160	W
Derating factor		1.07	W/ $^\circ C$
Single pulse avalanche energy (Note 2)	$E_{AS}$	550	mJ
Operating Junction and Storage Temperature Range	$T_J, T_{STG}$	-55 To 175	$^\circ C$

**Notes** 1.Repetitive Rating: Pulse width limited by maximum junction temperature

2.EAS condition:  $T_J=25^\circ C$ ,  $V_{DD}=37.5V$ ,  $V_G=10V$ ,  $L=0.5mH$

**Table 2. Thermal Characteristic**

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-Case (Maximum)	$R_{thJC}$	0.94	$^{\circ}\text{C}/\text{W}$
Thermal Resistance, Junction-to-Ambient (Maximum)	$R_{thJA}$	63	$^{\circ}\text{C}/\text{W}$

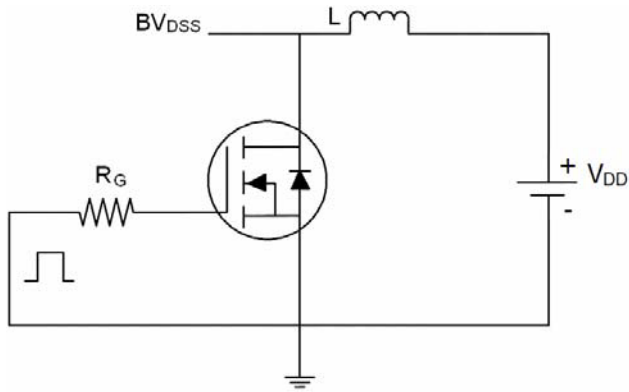
**Table 3. Electrical Characteristics ( $T_c=25^{\circ}\text{C}$  unless otherwise noted)**

Parameter	Symbol	Condition	Min	Typ	Max	Unit
On/off states						
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0V I <sub>D</sub> =250μA	75	84	-	V
Zero Gate Voltage Drain Current(Tc=25℃)	I <sub>DSS</sub>	V <sub>DS</sub> =75V,V <sub>GS</sub> =0V	-	-	1	μA
Zero Gate Voltage Drain Current(Tc=125℃)	I <sub>DSS</sub>	V <sub>DS</sub> =75V,V <sub>GS</sub> =0V	-	-	10	μA
Gate-Body Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> =±20V,V <sub>DS</sub> =0V	-	-	±100	nA
Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =V <sub>GS</sub> ,I <sub>D</sub> =250μA	2	2.85	4	V
Drain-Source On-State Resistance	R <sub>DS(ON)</sub>	V <sub>GS</sub> =10V, I <sub>D</sub> =40A	-	7	8.5	mΩ
Dynamic Characteristics						
Forward Transconductance	g <sub>FS</sub>	V <sub>DS</sub> =5V,I <sub>D</sub> =30A	-	60	-	S
Input Capacitance	C <sub>iss</sub>	V <sub>DS</sub> =25V,V <sub>GS</sub> =0V, F=1.0MHz	-	3400	-	PF
Output Capacitance	C <sub>oss</sub>		-	290	-	PF
Reverse Transfer Capacitance	C <sub>rss</sub>		-	221	-	PF
Total Gate Charge	Q <sub>g</sub>	V <sub>DS</sub> =30V,I <sub>D</sub> =30A, V <sub>GS</sub> =10V	-	94	-	nC
Gate-Source Charge	Q <sub>gs</sub>		-	16	-	nC
Gate-Drain Charge	Q <sub>gd</sub>		-	24	-	nC
Switching times						
Turn-on Delay Time	t <sub>d(on)</sub>	V <sub>DD</sub> =30V,I <sub>D</sub> =2A,R <sub>L</sub> =15Ω V <sub>GS</sub> =10V,R <sub>G</sub> =2.5Ω	-	15	-	nS
Turn-on Rise Time	t <sub>r</sub>		-	11	-	nS
Turn-Off Delay Time	t <sub>d(off)</sub>		-	52	-	nS
Turn-Off Fall Time	t <sub>f</sub>		-	13	-	nS
Source- Drain Diode Characteristics						
Source-drain current(Body Diode)	I <sub>SD</sub>		-	-	78	A
Pulsed Source-drain current(Body Diode)	I <sub>SDM</sub>		-	-	312	A
Forward on voltage <sup>(Note 1)</sup>	V <sub>SD</sub>	Tj=25℃,I <sub>SD</sub> =40A,V <sub>GS</sub> =0V	-	-	1.2	V
Reverse Recovery Time <sup>(Note 1)</sup>	t <sub>rr</sub>	Tj=25℃,I <sub>F</sub> =75A,di/dt=100A/μs	-	-	33	nS
Reverse Recovery Charge <sup>(Note 1)</sup>	Q <sub>rr</sub>		-	-	54	nC
Forward Turn-on Time	t <sub>on</sub>	Intrinsic turn-on time is negligible(turn-on is dominated by L <sub>S</sub> +L <sub>D</sub> )				

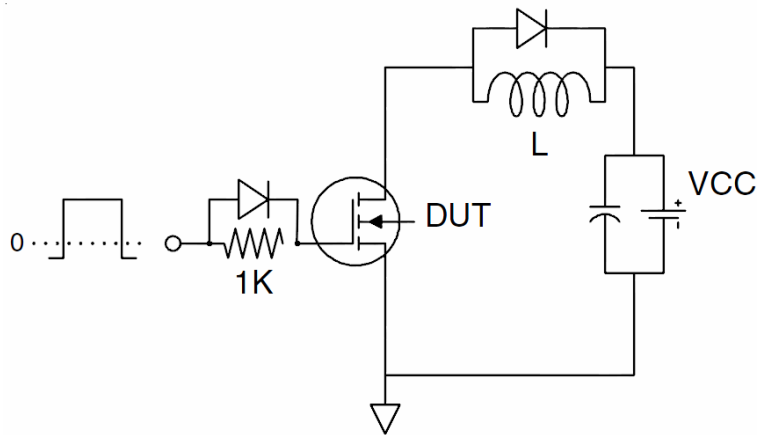
Notes 1. Pulse Test: Pulse Width  $\leq 300\mu s$ , Duty Cycle  $\leq 1.5\%$ ,  $R_G=25\Omega$ , Starting  $T_j=25^{\circ}\text{C}$

## Test Circuit

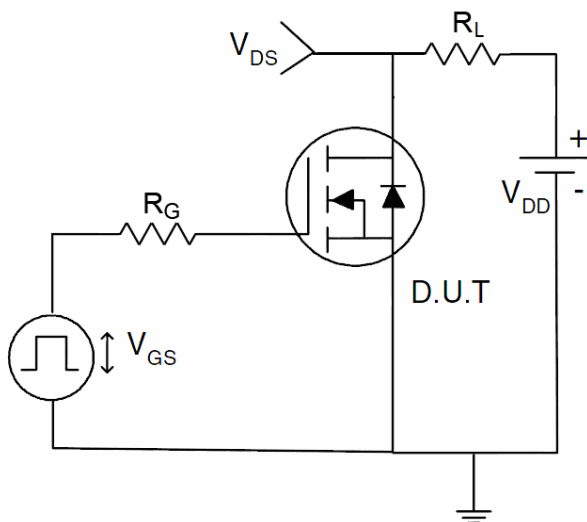
### 1) $E_{AS}$ test circuit



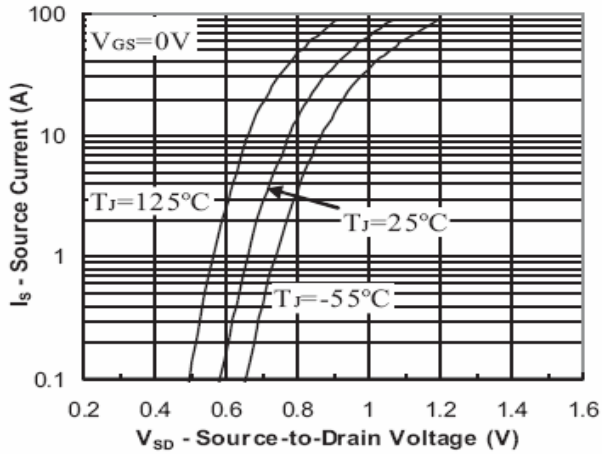
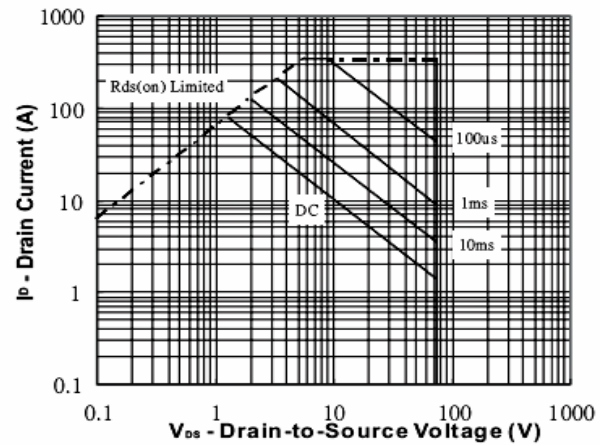
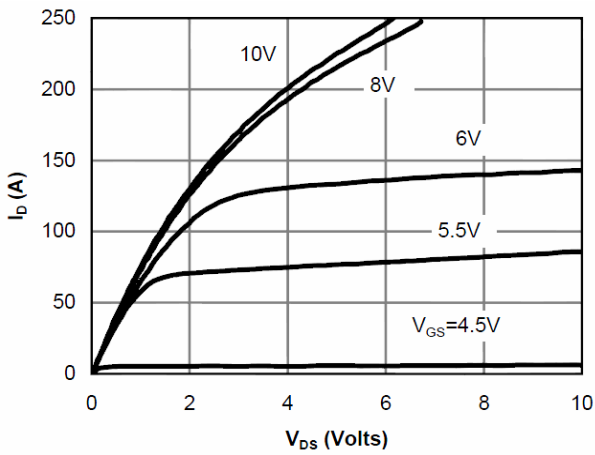
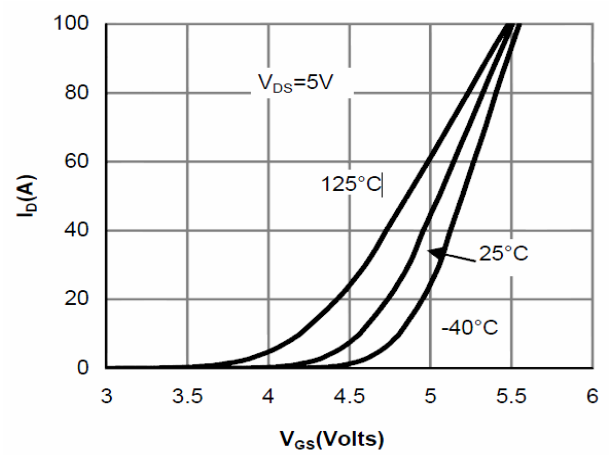
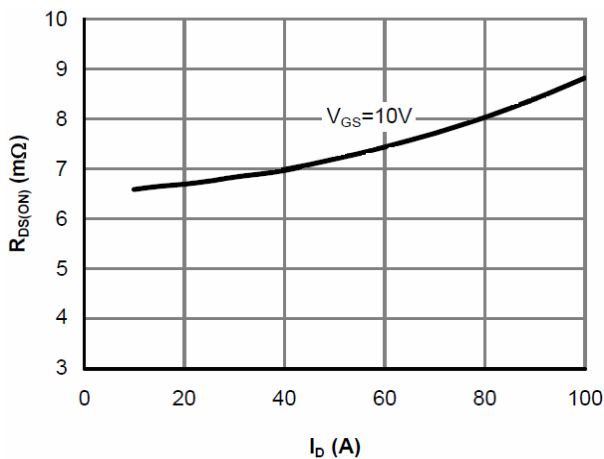
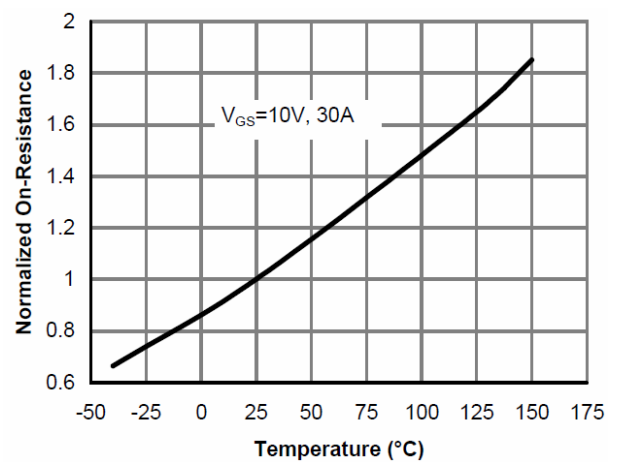
### 2) Gate charge test circuit

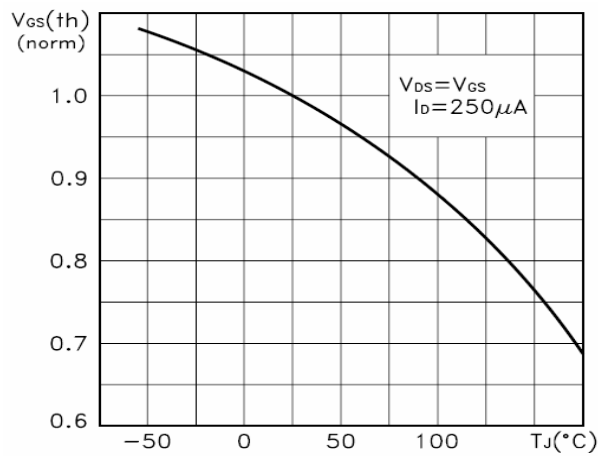
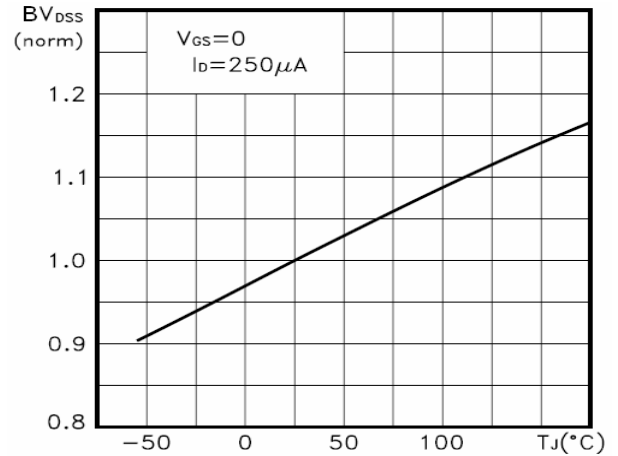
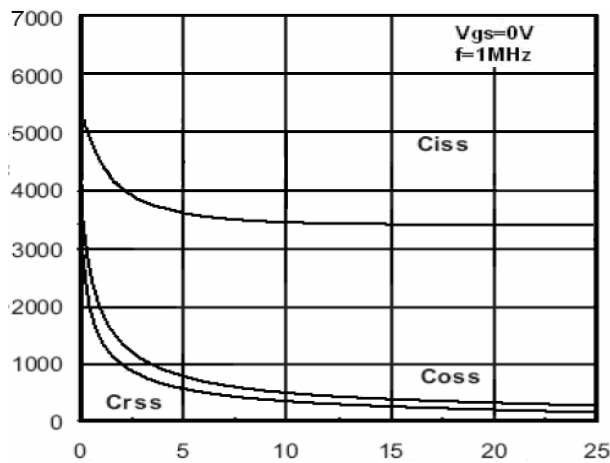
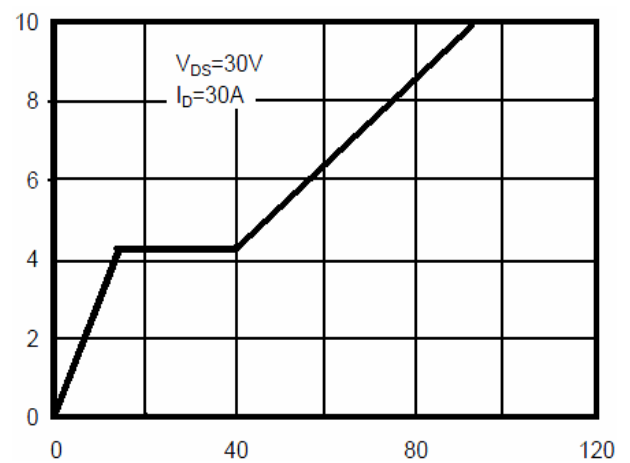


### 3) Switch Time Test Circuit



## Typical Electrical and Thermal Characteristics (curves)

**Figure1. Safe operating area**

**Figure2. Source-Drain Diode Forward Voltage**

**Figure3. Output characteristics**

**Figure4. Transfer characteristics**

**Figure5. Static drain-source on resistance**

**Figure6.  $R_{DS(on)}$  vs Junction Temperature**


**Figure7.  $BV_{DSS}$  vs Junction Temperature**

**Figure8.  $V_{GS(th)}$  vs Junction Temperature**

**Figure9. Capacitance**

**Figure10. Gate charge waveforms**

**Figure11. Normalized Maximum Transient Thermal Impedance**
